Pentor:Haining Yang

Methods of Forming Metal-Comprising Materials and Capacitor

Electrodes; and Capacitor Constructions

Assignee:

Micron Technology, Inc.

Serial No.: 09/932,236

Filed:

August 16, 2001

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

PURSUANT TO 37 C.F.R. §§ 1.56, 1.97 AND 1.98

The Examiner's attention is directed to the references which are listed on the attached Form PTO-1449, copies of which are attached. No admission is made regarding whether all the submitted references are prior art.

Citation of the referenced art is respectfully requested.

This Supplemental Information Disclosure Statement is being filed after the filing of an RCE and before the mailing date of a first Office Action. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

Respectfully submitted,

By:

Róbert C. Hyta

Reg. No. 46,791 Wells St. John P.S.

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